Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/655,229	CHANG, CHUNG NAN
Examiner	Art Unit
Shin-Hon Chen	2131

	SEARCHED					
Class	Subclass	Date	/Examiner			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
713	168,171	10/30/2006	S.C.			
380	259,282	10/30/2006	S.C.			
380	285,286	10/30/2006	S.C.			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT, PGPUB, DERWENT, JPO, EPO	10/30/2006	S.C.		